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Phase evolution and microwave dielectric properties of novel $\text{LiAl}_{5-x}\text{Zn}_x\text{O}_{8-0.5x}\text{-based}\ (0 \le x \le 0.5)$ ceramics

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Abstract

Novel $\text{LiAl}_{5-x}\text{Zn}_x\text{O}_{8-0.5x}$ microwave dielectric ceramics were synthesized through a solid-state reaction route. Phase evolution of $\text{LiAl}_{5-x}\text{Zn}_x\text{O}_{8-0.5x}$ was determined by XRD analysis. The XRD results indicated that the phase compositions had a $P4_332$ space group when $0 \le x \le 0.2$ and a spinel structure when $0.3 \le x \le 0.5$. The dielectric constant (ε_r) of this series' solid solutions decreased with the increase in Zn doping content, which was in good agreement with the Clausius-Mossotti relation. Oxygen vacancy and the decreased degree of order degraded the quality factor $(Q \times f)$ of the two structures. The deterioration in quality factor was further verified by impedance spectroscopy. The temperature coefficient of the resonant frequency (τ_f) decreased with the increase in x and was correlated with the unit cell volume. Finally, CaTiO_3 was used as a compensation material to obtain a near-zero τ_f of the LiAl_5O_8 ceramic.

KEYWORDS

dielectric materials/properties, electroceramics, microstructure, microwaves

1 | INTRODUCTION

The development of wireless communication systems requires electronic devices and substrates to have high frequency applications, miniaturization capabilities, and low-loss properties. $^{1-3}$ Dielectric ceramics with low $\varepsilon_{\rm r}$ and high $Q \times f$ are important materials for resonators, filters, and other key components from terrestrial to satellite communication systems, including the Internet of Thing (IoT), RFID, DBS TV, GPS, etc. Thus, these materials are gaining attention for academic and commercial purposes. $^{4-6}$

Various microwave dielectric ceramic systems, such as Bi_2O_3 – TiO_2 – V_2O_5 , (Sr, Ca) TiO_3 –LnAlO₃ (Ln = La, Nd, Sm), and BaO–Ln₂O₃– TiO_2 , 7.8 with high $Q \times f$ have attracted considerable research attention. Li₂O–Al₂O₃

ceramic systems, including Li₅AlO₄, LiAlO₂, and LiAl₅O₈, have seldom been studied for the application as microwave dielectric materials. In the past few years, we have investigated the LiAlO₂ ceramics for microwave dielectric application. On the other hand, the use of LiAl₅O₈ material as microwave dielectric ceramics have not been reported before. The LiAl₅O₈ compound with *P*4₃32 space group is a cubic ordered structure of four formula units in the unit cell Al₈^{IV}(Li₄Al₁₂)^{VI}O₃₂, and in the octahedral (o) sites there exist 1:3 ordering of Li: Al.¹⁰ A previous solid-state magic angle spinning nuclear magnetic resonance spectrum analysis on the LiAl₅O₈ compound showed that the substitution of Zn²⁺ and Mg²⁺ ions does not affect the distribution in octahedral sites of all the Li⁺ ions. However, Al³⁺ ions in octahedral (o) and tetrahedral (t) sites are affected and

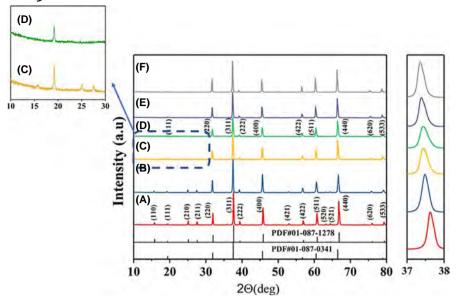


FIGURE 1 XRD patterns of LiAl_{5-x}Zn_xO_{8-0.5x} ($0 \le x \le 0.5$) ceramics at 1600°C for 6 h: (A) x = 0; (B) x = 0.1; (C) x = 0.2; (D) x = 0.3, (E) x = 0.4, (F) x = 0.5

redistributed. An infrared spectrum analysis of Zn^{2+} -doped $LiAl_5O_8$ ceramic indicated that increased Zn^{2+} substitution content can result in an increasingly disordered form. ¹¹ The substitution of Zn^{2+} and Mg^{2+} ions for Al^{3+} ions also induces the phase transition of the $LiAl_5O_8$ compound.

In this work, $\text{LiAl}_{5-x}\text{Zn}_x\text{O}_{8-0.5x}$ materials were sintered through conventional solid-state method. Then the effects of Zn^{2+} ion substitute to the Al^{3+} ion sites on the properties of the LiAl_5O_8 compound were investigated. The relationship among the crystal structure, phase transition, and microwave dielectric properties of the $\text{LiAl}_{5-x}\text{Zn}_x\text{O}_{8-0.5x}$ ceramics was studied.

2 | EXPERIMENTAL PROCEDURE

LiAl_{5-x}Zn_xO_{8-0.5x} materials were prepared by the solid-state reaction method. Stoichiometric Li₂CO₃, ZnO, and Al₂O₃ reagents were mixed using alcohol by ball milling. The dried powder was calcined in a furnace for 900°C. Then, the calcined powder was milled again in the same manner as before. The powder was pressed in a disk and sintered in air for 1600°C. A CaTiO₃ commercial reagent with a ratio of (1 - y) LiAl₅O₈ + y CaTiO₃ (y = 0.02-0.08) was added to the calcined LiAl₅O₈ powder in the same manner as discussed above and then sintered at a furnace for 1500°C.

The microstructure of thermal etching samples was examined by scanning electron microscopy (SEM). The crystal structure of $\text{LiAl}_{5-x}\text{Zn}_x\text{O}_{8-0.5x}$ ($0 \le x \le 0.5$) ceramics was measured using X-ray diffractometer (XRD). Then using GSAS software¹² to refine the XRD data and obtain the lattice parameters.

The microwave dielectric properties of the $\text{LiAl}_{5-x}\text{Zn}_x\text{O}_{8-0.5x}$ ceramics were recorded in a microwave

network analyzer using the Hakki and Coleman methods.¹³ Furthermore, the τ_f value was calculated using

$$\tau_f = \frac{1}{f(T_0)} \frac{[f(T_1) - f(T_0)]}{T_1 - T_0},\tag{1}$$

 $f(T_0)$ and $f(T_1)$ represent the resonant frequency at T_0 (30°C) and T_1 (80°C). An impedance analyzer was used to analyze the impedance spectroscopy of the samples in the frequency between 100 Hz and 10 MHz.

3 | RESULTS AND DISCUSSION

Figure 1 shows the XRD profiles of $\text{LiAl}_{5-x}\text{Zn}_x\text{O}_{8-0.5x}$ ceramics. As shown in the figure, the intensity of a few low-angle X-ray peaks, such as (110), (210), and (211), gradually weakens and then disappears at x=0.3 with the increased Zn content. When $x \leq 0.2$, the phase belongs to the $P4_332$ space group. When $0.3 \leq x \leq 0.5$, the series of materials have the Fd-3m space group of a spinel structure. Thus, the different Zn content substitutions on the Al site can lead to phase transition in the LiAl_5O_8 material, which occurs at approximately x=0.3.

The influence of Zn substitution of these samples on the lattice parameters was obtained using Rietveld refinement method. The refinement result of $\text{LiAl}_{5-x}\text{Zn}_x\text{O}_{8-0.5x}$ (x=0, 0.3) ceramics is shown in Figure 2 and Table 1. The lattice parameters and relative density of the samples are shown in Table 2. The table reveals that the lattice parameters increase as the increased Zn content. Moreover, the strongest peak (311) shifts to the lower 2 θ angle with the increase in x shown in Figure 1. Bragg's law ($2d\sin\theta = n\lambda$) posits that this phenomenon also indicates an increase in lattice parameters. According to the literature, ¹⁴ the radii of Zn^{2+} and Al^{3+} are

FIGURE 2 Rietveld refinement of (A) LiAl_{5-x}Zn_xO_{8-0.5x} (x = 0) and (B) LiAl_{5-x}Zn_xO_{8-0.5x} (x = 0.3) ceramic sintered at 1600°C for 6 h

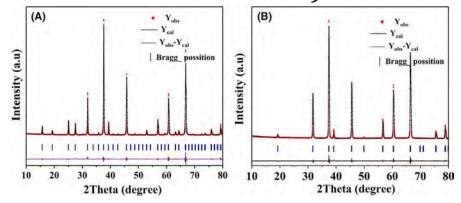


TABLE 1 Refined structural parameters of $\text{LiAl}_{5-x}\text{Zn}_x\text{O}_{8-0.5x}$ ceramic. The subscript 1 represent for x=0, and subscript 2 represent for x=0.3

Atom	x	у	z	Fraction	$R_{ m p}$	$R_{ m wp}$	χ²
Li1 ₁	0.625	0.625	0.625	1.00	0.061	0.087	4.931
Li2 ₁	0.07352	0.17648	0.125	1.00			
$Al1_1$	-0.00174	-0.00174	-0.00174	1.00			
A12 ₁	0.625	0.625	0.625	1.00			
A13 ₁	0.368008	-0.11801	0.125	1.00			
$O1_1$	0.115794	0.130097	0.130097	1.00			
$O2_1$	0.386521	0.386521	0.386521	1.00			
Li ₂	0.5	0.5	0.5	1.00	0.066	0.093	5.101
$Al1_2$	0.125	0.125	0.125	0.94			
$Al2_2$	0.5	0.5	0.5	0.94			
$Zn1_2$	0.125	0.125	0.125	0.06			
$Zn2_2$	0.5	0.5	0.5	0.06			
O_2	0.24895	0.24895	0.24895	1.00			

TABLE 2 Lattice parameters and relative densities of $LiAl_{5-x}Zn_xO_{8-0.5x}$ ceramics sintered at $1600^{\circ}C$ for 6 h in air

x	Lattice parameter a (Å)	Unit cell volume (Å ³)	Calculated density (g/cm ³)	Relative density (%)
0	7.908	494.538	3.624	92.3
0.1	7.914	495.665	3.657	95.5
0.2	7.938	500.188	3.664	95.7
0.3	7.949	502.270	3.689	96.2
0.4	7.961	504.548	3.713	96.3
0.5	7.968	505.881	3.743	96.1

0.74 and 0.535 Å, respectively. Therefore, the substitution of a Zn^{2+} ion (large radius) for an Al^{3+} ion (small radius) can enlarge the lattice parameters in the $LiAl_{5-x}Zn_xO_{8-0.5x}$ ceramics. All the samples, except for x=0, possess a relative density of more than 95%. This finding suggests that the Zn^{2+} substitution improves the density and that the compositions are compact when sintered at $1600^{\circ}C$.

The thermally etched morphology of the LiAl_{5-x}Zn_xO_{8-0.5x} $(0 \le x \le 0.5)$ materials is shown in Figure 3. All the samples

can be sintered well at 1600° C. It can be seen that there are very few pores in composition of x=0. However, with the increase in Zn content, the pores are gradually disappeared and almost no porosity in the compacted morphology of the samples could be obtained finally. This result further confirms the high relative density in Table 2. Of all the samples, the grain sizes are below $2 \, \mu m$, and the Zn doping content can slightly affect the grain size. The grain size of the samples gradually increases with the increased Zn content.

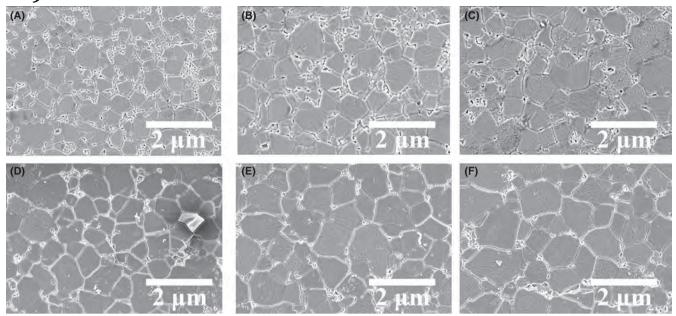


FIGURE 3 SEM micrograph of $LiAl_{5-x}Zn_xO_{8-0.5x}$ ($0 \le x \le 0.5$) ceramics sintered at 1600°C: (A) x = 0; (B) x = 0.1; (C) x = 0.2; (D) x = 0.3, (E) x = 0.4, (F) x = 0.5

The microwave dielectric properties of the $\text{LiAl}_{5-x}\text{Zn}_x\text{O}_{8-0.5x}$ ceramics are shown in Figure 4. ε_r gradually decreases from 8.43 to 8.04 with the increase in x from 0 to 0.5. Studies have shown that ε_r generally depends on porosity, microstructure, polarizability, and the secondary phase. The corrected dielectric constant values ($\varepsilon_{\text{corr}}$) were used in the following equation 16 :

$$\varepsilon_{\rm r} = \varepsilon_{\rm corr} \left(1 - \frac{3P \left(\varepsilon_{\rm corr} - 1 \right)}{2\varepsilon_{\rm corr} + 1} \right).$$
(2)

As shown in Table 3, the corrected porosity values (ε_{corr}) have the identical tendency of the measured ones, which is the same as the previous literature. ¹⁷ Shannon ¹⁸ reported that the total dielectric polarizability (α_D^T) of complex materials can be decomposed into ion polarizabilities (α_D). For the LiAl_{5-x}Zn_xO_{8-0.5x} series ceramics, the dielectric polarizability (α_D^T) of the can be calculated as

$$\alpha_{\rm D}^{\rm T}({\rm LiAl}_{5-x}{\rm Zn}_{x}{\rm O}_{8-0.5x}) = \alpha({\rm Li}^{+}) + (5-x)\alpha({\rm Al}^{3+}) + x\alpha({\rm Zn}^{2+}) + (8-0.5x)\alpha({\rm O}^{2-}). \tag{3}$$

According to the Clausius-Mossotti relation, $\varepsilon_{\rm c}$ can be calculated as

$$\varepsilon_{\rm c} = \frac{1 + 2b\alpha_{\rm D}^{\rm T}/V_{\rm m}}{1 - b\alpha_{\rm D}^{\rm T}/V_{\rm m}},\tag{4}$$

where $b=4\pi/3$, and $V_{\rm m}$ is the mole volume of the crystal and can be obtained through the Rietveld refinement value. The ionic-polarizability values of Li⁺, Al³⁺, Zn²⁺, and O²⁻ are 1.20, 0.78, 2.09, and 2.00 Å³, respectively. R As shown

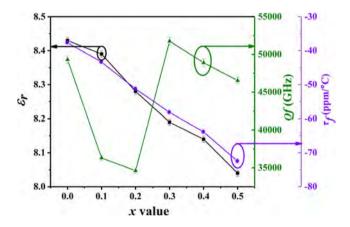


FIGURE 4 The ε_r , $Q \times f$ and τ_f values of the $\text{LiAl}_{5-x}\text{Zn}_x\text{O}_{8-0.5x}$ $(0 \le x \le 0.5)$ ceramics as a function of x value

TABLE 3 The calculated dielectric polarizability (α_D^T) , corrected dielectric constant ε_{corr} , and calculated dielectric constant ε_c value of Li $Al_{5-x}Zn_xO_{8-0.5x}$ $(0 \le x \le 0.5)$ ceramics

x	$\alpha_D^T(\mathring{A}^3)$	$V_{\rm m}({\rm \mathring{A}}^3)$	$\varepsilon_{ m r}$	$\varepsilon_{ m corr}$	$\boldsymbol{\varepsilon}_{\mathrm{c}}$
0	84.400	494.538	8.43	9.34	8.51
0.1	84.524	495.665	8.39	9.00	8.49
0.2	84.648	500.188	8.28	8.76	8.29
0.3	84.772	502.270	8.19	8.64	8.23
0.4	84.896	504.548	8.14	8.54	8.15
0.5	85.020	505.881	8.04	8.53	8.12

in Table 3, the calculated dielectric constant (ε_c) also has the same tendency as the observed ε_r .

Figure 4 shows the $Q \times f$ value of the LiAl_{5-x}Zn_xO_{8-0.5x} ceramics. For $P4_332$ space group structure, that is, $0 \le x \le 0.2$, the $Q \times f$ value decreases from 49 300 to 36 300 GHz. For the spinel structure, that is, $0.3 \le x \le 0.5$, $Q \times f$ decreases from 51 700 to 46 500 GHz. In general, lattice defects, porosity, disorder of ions, and band gap considerably influence the $Q \times f$ value. Given that we utilized the bivalent Zn^{2+} ion as substitute for the trivalent Al3+ ion, oxygen vacancy will be induced in the compound. This condition causes the deterioration of the $O \times f$ value for the two space group materials. The decreased degree of order can also lead to the degradation of the $Q \times f$ value. As reported by Ishimaru et al¹⁹ that the XRD pattern of the ordered spinel shows high intensity of all odd reflection peaks and low intensity of all even reflection peaks. Therefore, an order-disorder phase transition could be deduced by comparing the intensity of odd and even reflection peaks. The order parameter (ΔI) of the spinel structure can be calculated as²⁰

$$\Delta I = I_0 / \left(I_0 + I_e \right), \tag{5}$$

where $I_{\rm o}$ and $I_{\rm e}$ refer to the intensity of odd and even reflection peaks, respectively. Using Formula (4) for the order parameter, we listed the values of ΔI in Table 4 for the spinel structure with $0.3 \le x \le 0.5$, where $I_{\rm o}$ and $I_{\rm e}$ are the (311) and (400) peaks for the samples, respectively. The finding shows that the order parameters decrease with the increased Zn doping value. Therefore, for the spinel structure of the LiAl_{5-x}Zn_xO_{8-0.5x} (0.3 $\le x \le 0.5$) ceramics, the degree of order decreases with the increase in x. This situation results in the deterioration of $Q \times f$.

Figure 5 shows the measured impedance spectroscopy data of $\text{LiAl}_{5-x}\text{Zn}_x\text{O}_{8-0.5x}$ ceramics. Bulk conductivity (σ_b) value was obtained using the equivalent circuit fitting method through the original impedance data. Every temperature response in the Figure 5 was fitted using parallel R-CPE

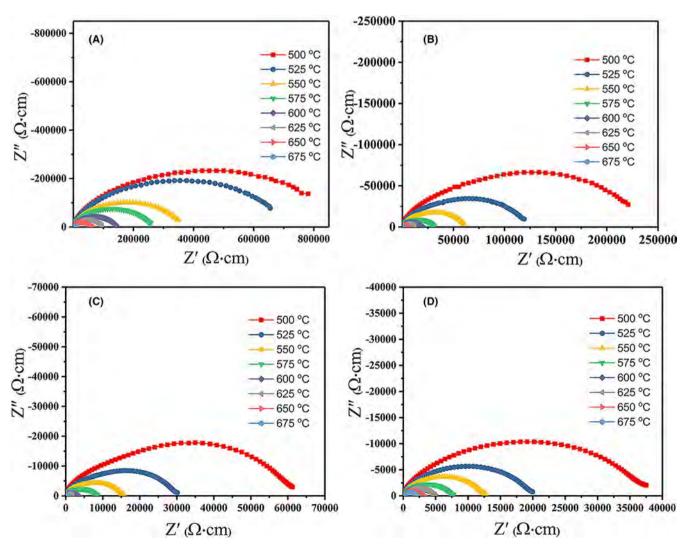


FIGURE 5 Original impedance spectroscopy data of $LiAl_{5-x}Zn_xO_{8-0.5x}$ ceramics: (A) x = 0; (B) x = 0.1; (C) x = 0.3, (D) x = 0.4

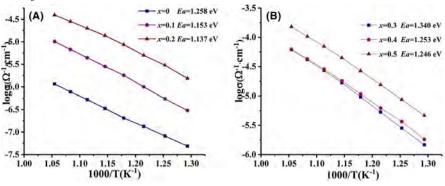


FIGURE 6 Arrhenius fitting plot from the temperature dependence of the bulk conductivity for LiAl_{5-x}Zn_xO_{8-0.5x} ceramics: (A) $0 \le x \le 0.2$; (B) $0.3 \le x \le 0.5$

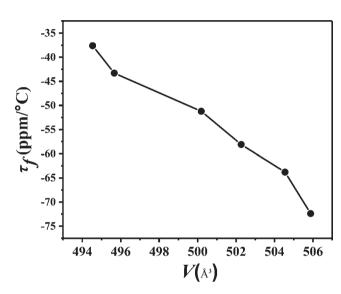


FIGURE 7 Variation of τ_f value as a function of unit-cell volume V

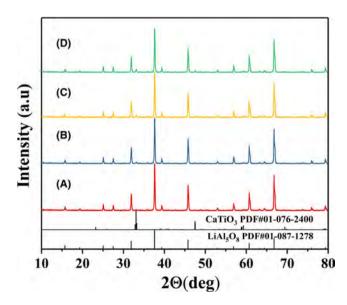


FIGURE 8 XRD patterns of the (1 - y) LiAl₅O₈ + y CaTiO₃ (y = 0.02-0.08) ceramics sintered at 1500°C in air for 6 h: (A) x = 0.02; (B) x = 0.04; (C) x = 0.06; (D) x = 0.08

elements. Then, the obtained bulk resistance R was converted to conductivity using Formula (6),

$$\sigma_{\rm b} = \frac{1}{R_{\rm b}} \frac{4t}{\pi D^2},\tag{6}$$

where t represents thickness and D represents diameter. The Arrhenius fit of the σ_b for $\text{LiAl}_{5-x}\text{Zn}_x\text{O}_{8-0.5x}$ ceramics of $0 \le x \le 0.2$ and $0.3 \le x \le 0.5$ are exhibited in Figure 6. As x increases from 0 to 0.2, the calculated activation energy (E_a) has a decreasing tendency from 1.258 to 1.137 eV. Meanwhile, E_a decreases from 1.340 to 1.264 eV when x changes from 0.3 to 0.5. On the basis of the approximation of the intrinsic band gap, $E_g \approx 2E_a$, $^{21-23}$ the conductivity was deduced with the increase in x from 0 to 0.2 and 0.3 to 0.5. Thus, the samples at x=0 and 0.3 have the highest quality factor for the different lattice structures, that is, $0 \le x \le 0.2$ and $0.3 \le x \le 0.5$, respectively, of the $\text{LiAl}_{5-x}\text{Zn}_x\text{O}_{8-0.5x}$ ceramics.

As x increases from 0 to 0.5, τ_f increases from -38 ppm/°C to -72 ppm/°C in the negative direction, as shown in Figure 4. Previous studies^{24–26} indicated that the τ_f value is proportional to the relative magnitude of the cell volume of the compound. Figure 7 shows that τ_f decreases with the increase in unit cell volume, which is consistent with previous results.

TABLE 4 Order parameter ΔI as a function of x value

x	$I_{0}(311)$	$I_{\rm e}(400)$	ΔI
0.3	100	39.9	0.715
0.4	100	42.6	0.701
0.5	100	46.3	0.684

TABLE 5 Microwave dielectric properties of (1 - y)LiAl₅O₈ + y CaTiO₃ (y = 0.02-0.08) ceramics sintered at 1500°C for 6 h

y Value	$arepsilon_{ m r}$	$Q \times f(GHz)$	τ_f (ppm/°C)
0.02	8.66	36 800	-25
0.04	8.99	26 400	-13
0.06	9.33	21 300	-5
0.08	9.76	15 200	12

For the application of microwave dielectric ceramics, a near-zero τ_f value is needed. ²⁷ In general, some positive τ_f value materials, such as TiO2 and CaTiO3, are utilized as compensation materials for negative τ_f value materials to acquire a nearzero τ_f value. The XRD profile of (1 - y) LiAl₅O₈ + y CaTiO₃ (y = 0.02-0.08) ceramics exhibit only two phases of LiAl₅O₈ and CaTiO₃ shown in Figure 8. The intensity of main peak of CaTiO₃ phase at about 33° of the XRD pattern is strengthen with the increase in y. This condition indicates an increased CaTiO₃ content. Table 5 lists the ε_r , $Q \times f$, and τ_f value of (1 - y) $LiAl_5O_8 + y CaTiO_3$ (y = 0.02-0.08) ceramics. As shown from this table, ε_r monotonously increases from 8.66 to 9.76, while $Q \times f$ decreases significantly from 36 800 to 15 200 GHz. On the other hand, τ_f value varies from -25 to 12 ppm/°C, which means that by adjusting the content of CaTiO₃ a near zero τ_f value can be achieved. In this case, the best τ_f value can be achieved at y = 0.06 with -5 ppm/°C. The microwave dielectric properties of two phase materials generally obey the mixing rules:28,29

$$\ln \varepsilon_{\rm r} = v_1 \ln \varepsilon_1 + v_2 \ln \varepsilon_2,\tag{7}$$

$$Q^{-1} = v_1 Q_1^{-1} + v_2 Q_2^{-1}, (8)$$

$$\tau_f = v_1 \tau_{f1} + v_2 \tau_{f2}, \tag{9}$$

$$v_1 + v_2 = 1, (10)$$

where v_1 and v_2 represent the volume fraction of the components. According previous study of CaTiO₃ ceramic, it has the trait of high ε_r , low $Q \times f$, and large τ_f value.^{30,31} This character of the CaTiO₃ ceramic increases ε_r and τ_f and decreases the $Q \times f$ of (1 - y) LiAl₅O₈ + y CaTiO₃ (y = 0.02-0.08) ceramics with the increase in y (Table 5).

4 | CONCLUSIONS

A series of $\text{LiAl}_{5-x} \text{Zn}_x \text{O}_{8-0.5x}$ ($0 \le x \le 0.5$) microwave dielectric ceramics with good crystallinity of uniform crystal grains and high relative density were investigated. The phase transition of this series solid solutions occurred at approximately x = 0.3. A pure phase with a cubic structure ($P4_332$) was formed with the increase in x from 0 to 0.2, whereas a spinel structure ($F4_3$ m) was obtained with the increase in x from 0.3 to 0.5. The lattice parameter (a) monotonously increased from 7.908 to 7.968 Å with the increase in x from 0 to 0.5 through Rietveld refinement. An observed ε_r very close to the calculated ε_c was obtained through the Clausius-Mossotti relation, and it monotonously decreased from 8.43 to 8.04 with the increase in x from 0 to 0.5. For the samples of the $P4_332$ space group structure, $Q \times f$ dropped from 49 300 to 36 300 GHz. For the spinel structure, $Q \times f$ dropped from

51 700 to 46 500 GHz. The defect of oxygen ion and the decreased degree of order caused this reduction in $Q \times f$. τ_f decreased from -38 ppm/°C to -72 ppm/°C in the negative direction with the increase in x from 0 to 0.5. Moreover, τ_f was correlated with the unit cell volume of $\text{LiAl}_{5-x}\text{Zn}_x\text{O}_8$ $_{-0.5x}$ for the $P4_332$ and Fd-3m space group structures. The CaTiO_3 material with a positive τ_f was used to compensate for the LiAl_5O_8 material with a negative τ_f to obtain a temperature stable material for practical applications. The (1-y) $\text{LiAl}_5\text{O}_8 + y$ CaTiO_3 ceramic showed a near-zero τ_f when y = 0.06 and had microwave dielectric properties of $\varepsilon_r = 9.33$, $Q \times f = 21$ 300 GHz, and $\tau_f = -5$ ppm/°C.

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